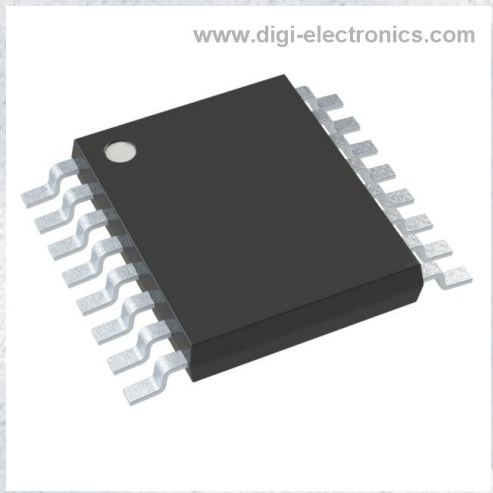
NPIC6C596APW-Q100J Datasheet



DiGi Electronics Part Number	NPIC6C596APW-Q100J-DG
Manufacturer	Nexperia USA Inc.
Manufacturer Product Number	NPIC6C596APW-Q100J
Description	IC SHIFT REGISTER 8BIT 16TSSOP
Detailed Description	Shift Shift Register 1 Element 8 Bit 16-TSSOP

https://www.DiGi-Electronics.com

Tel: +00 852-30501935

RFQ Email: Info@DiGi-Electronics.com

Purchase and inquiry

Manufacturer Product Number:	Manufacturer:
NPIC6C596APW-Q100J	Nexperia USA Inc.
Series:	Product Status:
-	Obsolete
Logic Type:	Output Type:
Shift Register	Open Drain
Number of Elements:	Number of Bits per Element:
1	8
Function:	Voltage - Supply:
Serial to Parallel, Serial	2.3V ~ 5.5V
Operating Temperature:	Grade:
-40°C ~ 125°C	Automotive
Qualification:	Mounting Type:
AEC-Q100	Surface Mount
Package / Case:	Supplier Device Package:
16-TSSOP (0.173", 4.40mm Width)	16-TSSOP
Base Product Number:	
NPIC6C596	

Environmental & Export classification

RoHS Status:	Moisture Sensitivity Level (MSL):
ROHS3 Compliant	1 (Unlimited)
REACH Status:	ECCN:
REACH Unaffected	EAR99
HTSUS:	
8542.39.0001	

NPIC6C596A-Q100

Power logic 8-bit shift register; open-drain outputs

Rev. 2 — 26 June 2020 Product data sheet

1. General description

The NPIC6C596A-Q100 is an 8-bit serial-in/serial or parallel-out shift register with a storage register and open-drain outputs. Both the shift and storage register have separate clocks. The device features a serial input (DS) and a serial output (Q7S) to enable cascading and an asynchronous reset $\overline{MR}$ input. A LOW on $\overline{MR}$ resets both the shift register and storage register. Data is shifted on the LOW-to-HIGH transitions of the SHCP input. The data in the shift register is transferred to the storage register on a LOW-to-HIGH transition of the STCP input. If both clocks are connected together, the shift register is always one clock pulse ahead of the storage register. To provide additional hold time in cascaded applications, the serial output QS7 is clocked out on the falling edge of SHCP. Data in the storage register drives the gate of the output extended-drain NMOS (EDNMOS) transistor whenever the output enable input ($\overline{OE}$) is LOW. A HIGH on $\overline{OE}$ causes the outputs to assume a high-impedance OFF-state. Operation of the $\overline{OE}$ input does not affect the state of the registers. The open-drain outputs are 33 V/100 mA continuous current extended-drain NMOS transistors designed for use in systems that require moderate load power such as LEDs. Integrated voltage clamps in the outputs, provide protection against inductive transients. These voltage clamps make the device suitable for power driver applications such as relays, solenoids and other low-current or medium-voltage loads.

This product has been qualified to the Automotive Electronics Council (AEC) standard Q100 (Grade 1) and is suitable for use in automotive applications.

2. Features and benefits

- Automotive product qualification in accordance with AEC-Q100 (Grade 1)
  - Specified from -40 °C to +85 °C and from -40 °C to +125 °C
- Wide supply range 2.3 V to 5.5 V
- Low R_{DSon}
- Eight Power EDNMOS transistor outputs of 100 mA continuous current
- 250 mA current limit capability
- Output clamping voltage 33 V
- 30 mJ avalanche energy capability
- Enhanced cascading for multiple stages
- All registers cleared with single input
- Low power consumption
- ESD protection:
  - HBM AEC-Q100-002 revision D exceeds 2500 V
  - CDM AEC-Q100-011 revision B exceeds 1000 V
- DHVQFN package with Side-Wettable Flanks enabling Automatic Optical Inspection (AOI) of solder joints

3. Applications

- LED sign
- Graphic status panel
- Fault status indicator

4. Ordering information

Table 1. Ordering information

Type number	Package			
	Temperature range	Name	Description	Version
NPIC6C596AD-Q100	-40 °C to +125 °C	SO16	plastic small outline package; 16 leads; body width 3.9 mm	SOT109-1
NPIC6C596APW-Q100	-40 °C to +125 °C	TSSOP16	plastic thin shrink small outline package; 16 leads; body width 4.4 mm	SOT403-1
NPIC6C596ABQ-Q100	-40 °C to +125 °C	DHVQFN16	plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 16 terminals; body 2.5 × 3.5 × 0.85 mm	SOT763-1

5. Functional diagram

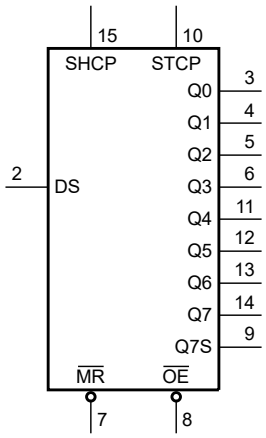


Fig. 1. Logic symbol

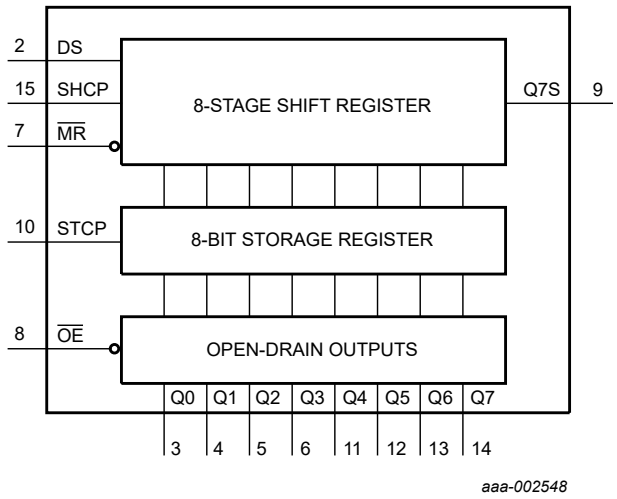


Fig. 2. Functional diagram

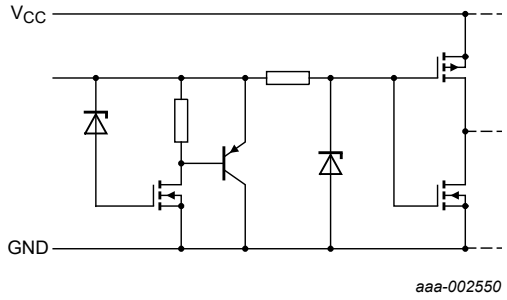


Fig. 3. Schematic of all inputs

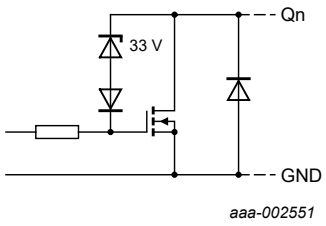


Fig. 4. Schematic of open-drain outputs (Qn)

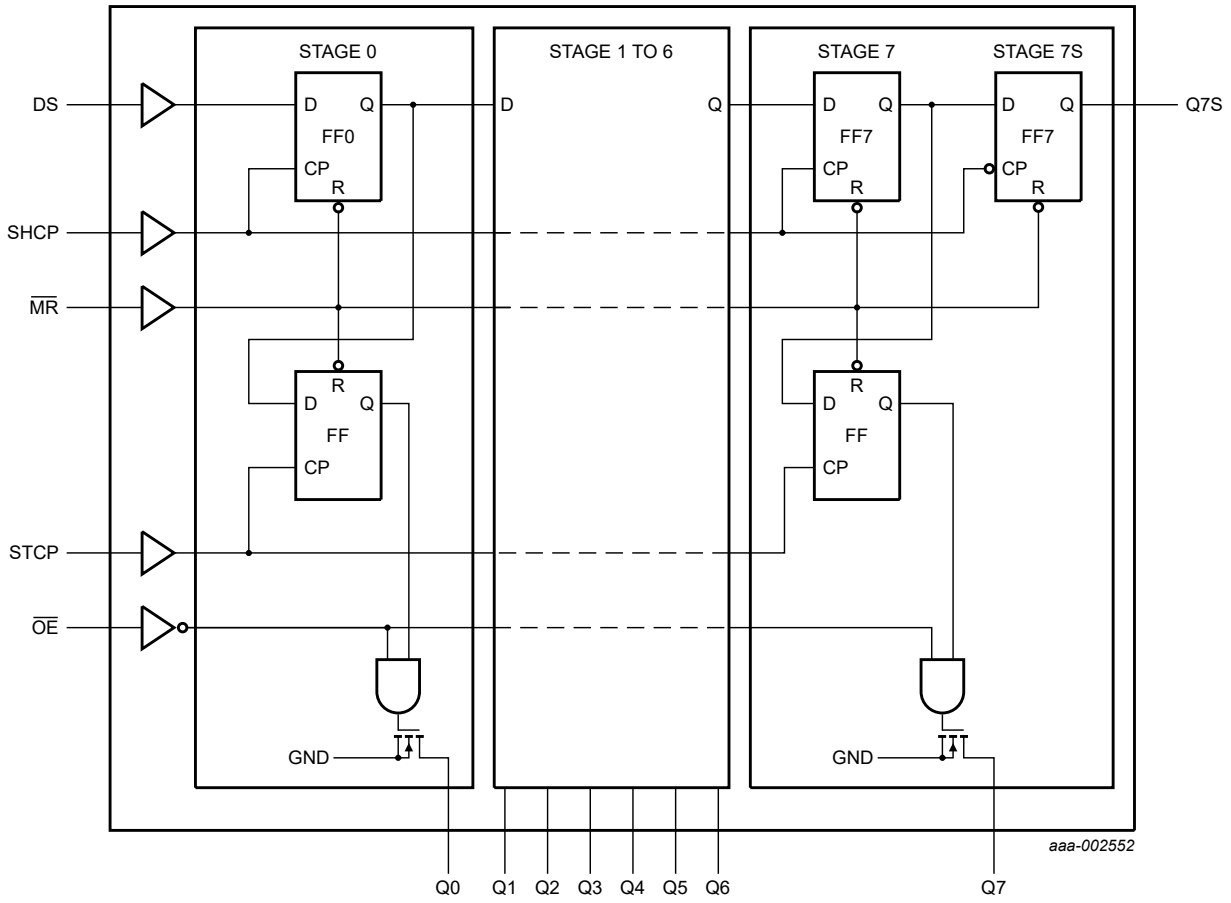


Fig. 5. Logic diagram

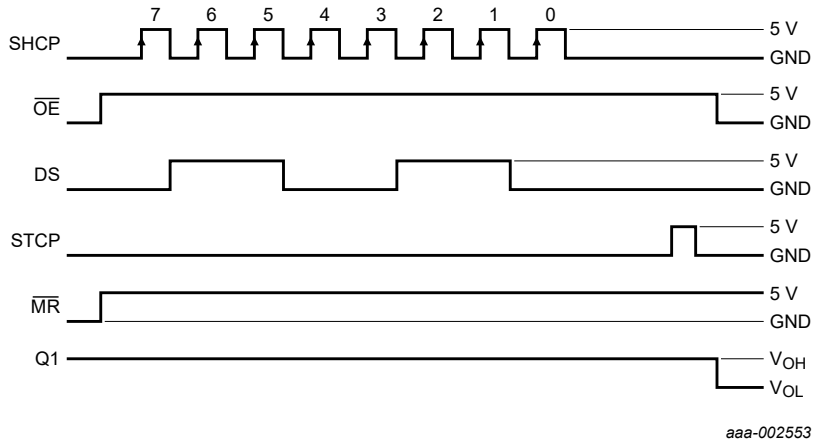


Fig. 6. Timing diagram

6. Pinning information

6.1. Pinning

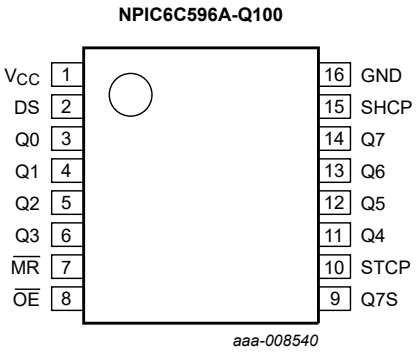
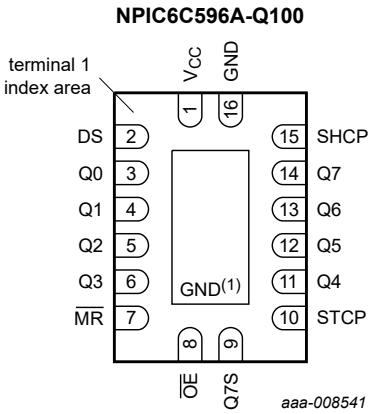


Fig. 7. Pin configuration SOT109-1 (SO16) and SOT403-1 (TSSOP16)



Transparent top view

(1) This is not a ground pin. There is no electrical or mechanical requirement to solder the pad. In case soldered, the solder land should remain floating or connected to GND.

Fig. 8. Pin configuration SOT763-1 (DHVQFN16)

6.2. Pin description

Table 2. Pin description

Symbol	Pin	Description
V_{CC}	1	supply voltage
DS	2	serial data input
Q0, Q1, Q2, Q3, Q4, Q5, Q6, Q7	3, 4, 5, 6, 11, 12, 13, 14	parallel data output (open-drain)
$\overline{MR}$	7	master reset (active LOW)
$\overline{OE}$	8	output enable input (active LOW)
Q7S	9	serial data output
STCP	10	storage register clock input
SHCP	15	shift register clock input
GND	16	ground (0 V)

7. Limiting values

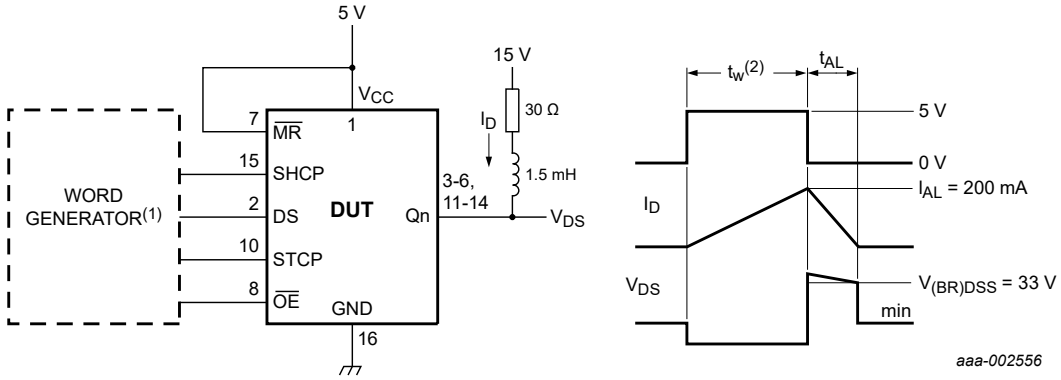
Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V_{CC}	supply voltage			-0.5	+7.0	V
V_I	input voltage			-0.3	+7.0	V
V_{DS}	drain-source voltage	power EDNMOS drain-source voltage	[1]	-	+33	V
$I_{d(SD)}$	source-drain diode current	continuous		-	250	mA
		pulsed	[2]	-	500	mA
I_D	drain current	T_{amb} = 25 °C				
		continuous; each output; all outputs on		-	100	mA
		pulsed; each output; all outputs on	[2]	-	250	mA
I_{DM}	peak drain current	single output; T_{amb} = 25 °C	[2]	-	250	mA
E_{AS}	non-repetitive avalanche energy	single pulse; see Fig. 9	[3]	-	30	mJ
I_{AL}	avalanche current	see Fig. 9	[3]	-	200	mA
T_{stg}	storage temperature			-65	+150	°C
P_{tot}	total power dissipation	T_{amb} = 25 °C	[4]			
		SO16		-	800	mW
		TSSOP16		-	725	mW
		DHVQFN16		-	1825	mW
		T_{amb} = 125 °C	[4]			
		SO16		-	160	mW
		TSSOP16		-	145	mW
		DHVQFN16		-	365	mW

[1] Each power EDNMOS source is internally connected to GND.
[2] Pulse duration ≤ 100 µs and duty cycle ≤ 2 %.
[3] V_{DS} = 15 V; starting junction temperature (T_j) = 25 °C; L = 1.5 H; avalanche current (I_{AL}) = 200 mA.
[4] For SO16 packages: above 25 °C the value of P_{tot} derates linearly with 6.4 mW/°C.
For TSSOP16 packages: above 25 °C the value of P_{tot} derates linearly with 5.8 mW/°C.
For DHVQFN16 packages: above 25 °C the value of P_{tot} derates linearly with 14.6 mW/°C.

7.1. Test circuit and waveform



(1) The word generator has the following characteristics: t_r, $t_f \leq 10$ ns; $Z_O = 50\ \Omega$
(2) The input pulse duration (t_W) is increased until peak current $I_{AL} = 200$ mA. Energy test level is defined as: $E_{AS} = I_{AL} \times V_{(BR)DSS} \times t_{AL}/2 = 30$ mJ.

Fig. 9. Test circuit and waveform for measuring single-pulse avalanche energy

8. Recommended operating conditions

Table 4. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{CC}	supply voltage		2.3	-	5.5	V
V_I	input voltage		0	-	5.5	V
I_D	drain current	pulsed drain output current; $V_{CC} = 5$ V; $T_{amb} = 25$ °C; all outputs on [1] [2]	-	-	250	mA
T_{amb}	ambient temperature		-40	-	+125	°C

[1] Pulse duration ≤ 100 µs and duty cycle ≤ 2 %.
[2] Technique should limit $T_j - T_{amb}$ to 10 °C maximum.

9. Static characteristics

Table 5. Static characteristics

At recommended operating conditions unless otherwise specified. Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	$T_{amb} = 25$ °C			Unit
			Min	Typ [1]	Max	
V_{IH}	HIGH-level input voltage	$V_{CC} = 3.0$ V to 5.5 V	$0.85V_{CC}$	-	-	V
V_{IL}	LOW-level input voltage	$V_{CC} = 3.0$ V to 5.5 V	-	-	$0.15V_{CC}$	V
V_{OH}	HIGH-level output voltage	serial data output Q7S; $V_I = V_{IH}$ or V_{IL}				
		$I_O = -20$ µA; $V_{CC} = 3.0$ V	2.64	4.49	-	V
		$I_O = -4$ mA; $V_{CC} = 3.0$ V	2.4	4.2	-	V
V_{OL}	LOW-level output voltage	serial data output Q7S; $V_I = V_{IH}$ or V_{IL}				
		$I_O = 20$ µA; $V_{CC} = 3.0$ V	-	0.005	0.12	V
		$I_O = 4$ mA; $V_{CC} = 3.0$ V	-	0.3	0.6	V
I_I	input leakage current	$V_{CC} = 5.5$ V; $V_I = V_{CC}$	-	-	1	µA

Symbol	Parameter	Conditions	T_{amb} = 25 °C			Unit
			Min	Typ [1]	Max	
$V_{(BR)DSS}$	drain-source breakdown voltage	I_D = 1 mA	33	37	-	V
V_{SD}	source-drain voltage	diode forward voltage; I_F = 100 mA	-	0.85	1.2	V
I_{CC}	supply current	logic supply current; V_{CC} = 5.5 V; V_I = V_{CC} or GND				
		all outputs off	-	0.004	200	µA
		all outputs on [2]	-	0.006	500	µA
		all outputs off; SHCP = 5 MHz; C_L = 30 pF; see Fig. 14 and Fig. 16	-	0.75	5	mA
$I_{O(nom)}$	nominal output current	V_{DS} = 0.5 V; T_{amb} = 85 °C; I_{out} = I_D [3] [4] [5]	-	140	-	mA
I_{DSX}	drain cut-off current	V_{CC} = 5.5 V; V_{DS} = 30 V	-	0.002	0.2	µA
		V_{CC} = 5.5 V; V_{DS} = 30 V; T_{amb} = 125 °C	-	0.15	0.3	µA
R_{DSon}	drain-source on-state resistance	see Fig. 17 and Fig. 18 [3] [4]				
		V_{CC} = 3.0 V; I_D = 50 mA	-	3.0	11	Ω
		V_{CC} = 3.0 V; I_D = 50 mA; T_{amb} = 125 °C		5.4	14	Ω
		V_{CC} = 3.0 V; I_D = 100 mA	-	3.1	12	Ω

[1] Typical values are measured at T_{amb} = 25 °C and V_{CC} = 5.0 V.
[2] Output currents below 250 mA current limit.
[3] Technique should limit T_j - T_{amb} to 10 °C maximum.
[4] These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.
[5] Nominal output current is defined for a consistent comparison between devices from different sources. It is the current that produces a voltage drop of 0.5 V at T_{amb} = 85 °C.

10. Dynamic characteristics

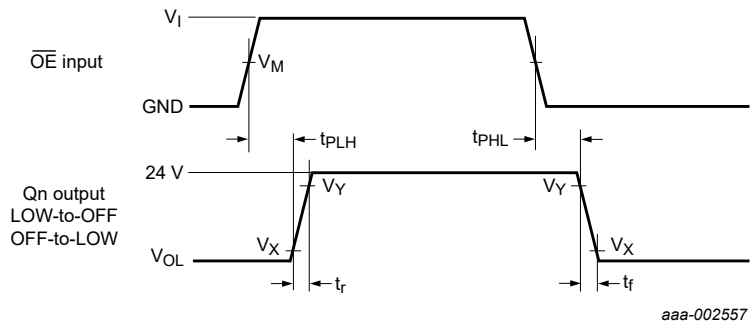
Table 6. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V); For test circuit, see Figure 14.

Symbol	Parameter	Conditions		T_{amb} = 25 °C			Unit
				Min	Typ [1]	Max	
t_{PLH}	LOW to HIGH propagation delay	$\overline{OE}$ to Qn; I_D = 75 mA; see Fig. 10 and Fig. 19		-	97	-	ns
t_{PHL}	HIGH to LOW propagation delay	$\overline{OE}$ to Qn; I_D = 75 mA; see Fig. 10 and Fig. 19		-	9	-	ns
t_r	rise time	$\overline{OE}$ to Qn; I_D = 75 mA; see Fig. 10 and Fig. 19		-	60	-	ns
t_f	fall time	$\overline{OE}$ to Qn; I_D = 75 mA; see Fig. 10 and Fig. 19		-	18	-	ns
t_{pd}	propagation delay	SHCP to Q7S; I_D = 75 mA; see Fig. 11	[2]	-	5	-	ns
f_{max}	maximum frequency	SHCP; I_D = 75 mA; see Fig. 11	[3]	-	-	10	MHz
t_{rr}	reverse recovery time	I_F = 100 mA; dI/dt = 10 A/µs; see Fig. 13	[4] [5]	-	120	-	ns
t_a	reverse recovery current rise time	I_F = 100 mA; dI/dt = 10 A/µs; see Fig. 13	[4] [5]	-	100	-	ns
t_{su}	set-up time	DS to SHCP; see Fig. 12		15	-	-	ns
t_h	hold time	DS to SHCP; see Fig. 12		15	-	-	ns
t_W	pulse width			40	-	-	ns

[1] Typical values are measured at T_{amb} = 25 °C and V_{CC} = 5.0 V.
[2] t_{pd} is the same as t_{PLH} and t_{PHL}.
[3] This is the maximum serial clock frequency assuming cascaded operation where serial data is passed from one stage to a second stage. The clock period allows for SHCP → Q7S propagation delay and setup time plus some timing margin.
[4] Technique should limit T_j - T_{amb} to 10 °C maximum.
[5] These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.

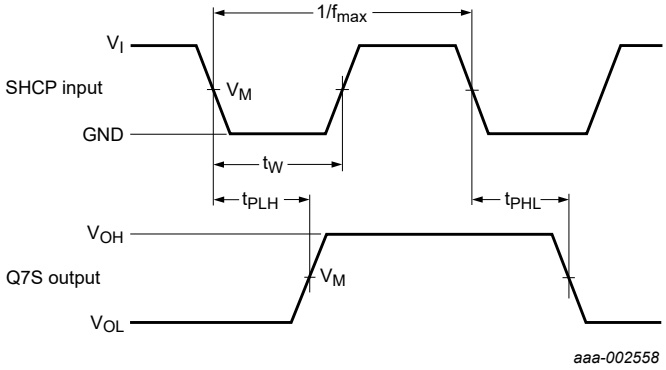
10.1. Test circuits and waveforms



Measurement points are given in Table 7.

V_{OL} is the typical output voltage drop that occurs with the output load.

Fig. 10. The output enable ($\overline{OE}$) input to data output (Qn) propagation delays and (Qn) output rise and fall times



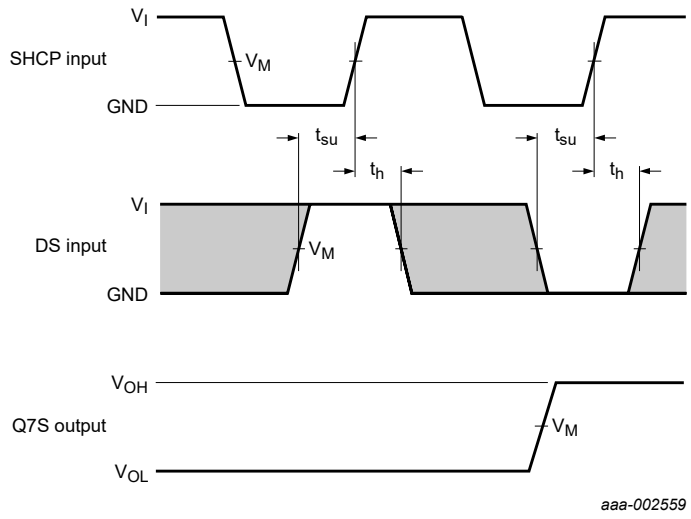
Measurement points are given in Table 7.

V_{OL} and V_{OH} are the typical output voltage levels that occur with the output load.

Fig. 11. The shift clock (SHCP) to serial data output (Q7S) propagation delays with the minimum shift clock pulse width and maximum shift clock frequency

Table 7. Measurement points

Supply voltage	Input	Output		
V_{CC}	V_M	V_M	V_X	V_Y
5 V	$0.5V_{CC}$	$0.5V_{DS}$	$0.1V_{DS}$	$0.9V_{DS}$



Measurement points are given in Table 8.

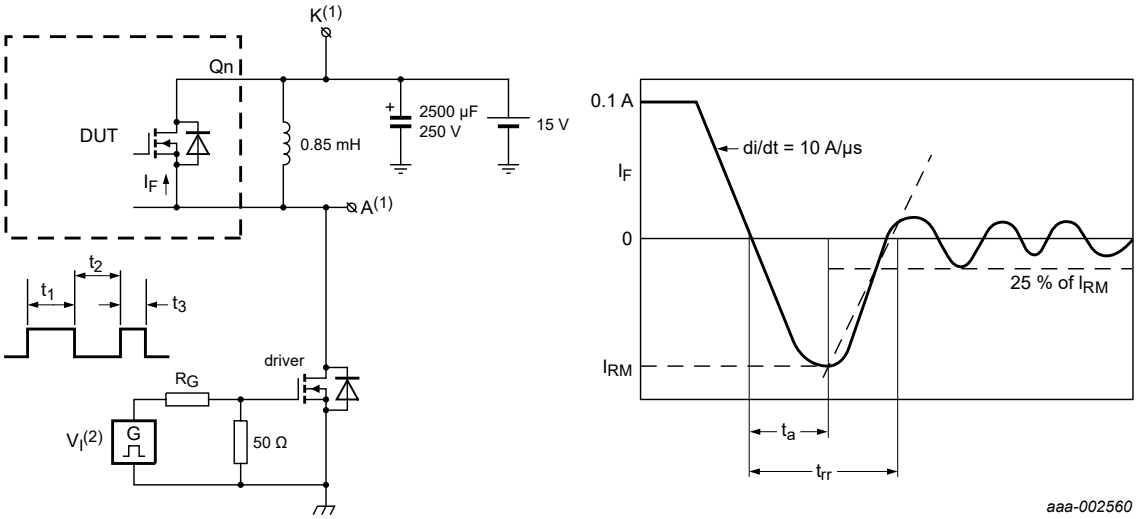
The shaded areas indicate when the input is permitted to change for predictable output performance.

V_{OL} and V_{OH} are the typical output voltage levels that occur with the output load.

Fig. 12. The data set-up and hold times for the serial data input (DS)

Table 8. Measurement points

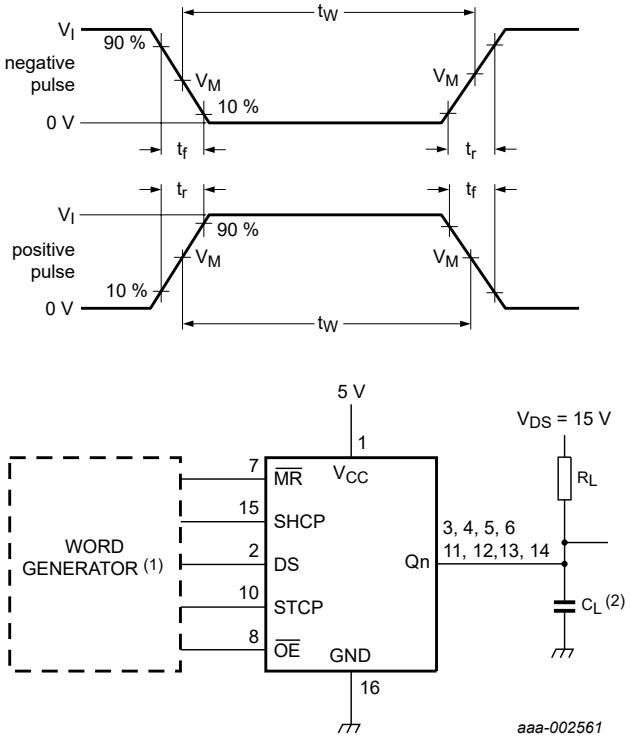
Supply voltage	Input	Output
V_{CC}	V_M	V_M
5 V	$0.5V_{CC}$	$0.5V_{CC}$



(1) The open-drain Qn terminal under test is connected to testpoint K.
All other terminals are connected together and connected to testpoint A.

(2) The V_I amplitude and R_G are adjusted for dI/dt = 10 A/µs.
A V_I double-pulse train is used to set I_F = 0.1 A, where t_1 = 10 µs, t_2 = 7 µs and t_3 = 3 µs.

Fig. 13. Test circuit and waveform for measuring reverse recovery current



(1) The word generator has the following characteristics:
t_r, t_f ≤ 10 ns;
t_W = 300 ns;
pulsed repetition rate (PRR) = 5 kHz;
Z_O = 50 Ω

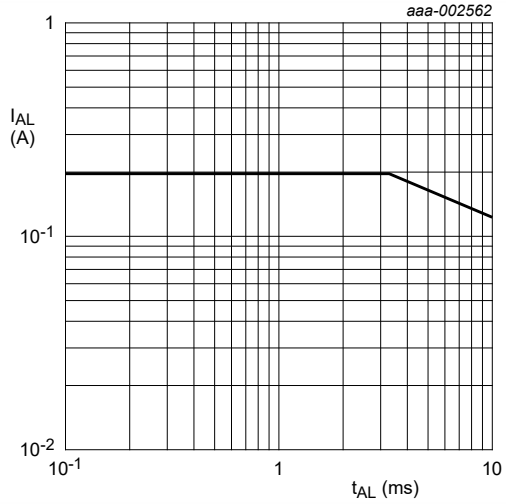
(2) C_L includes probe and jig capacitance.

Test data is given in Table 9. Definitions for test circuit:
V_{DS} = External voltage for Power EDNMOS drain-source voltage.
R_L = Load resistance.
C_L = Load capacitance including jig and probe capacitance.

Fig. 14. Test circuit for measuring switching times

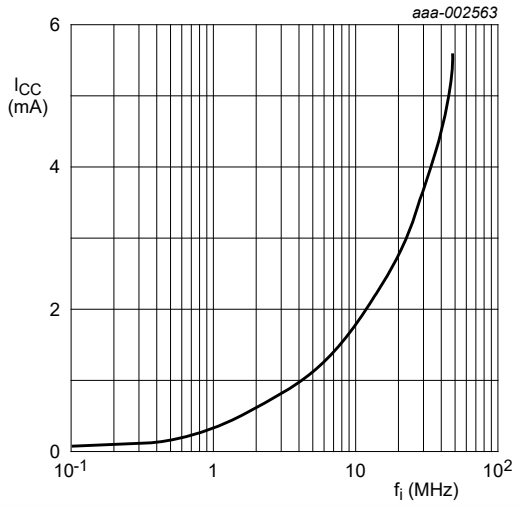
Table 9. Test data

Supply voltage	Input			Load	
	V_I	t_r, t_f	V_M	C_L	R_L
5 V	5 V	≤ 10 ns	50%	30 pF	200 Ω



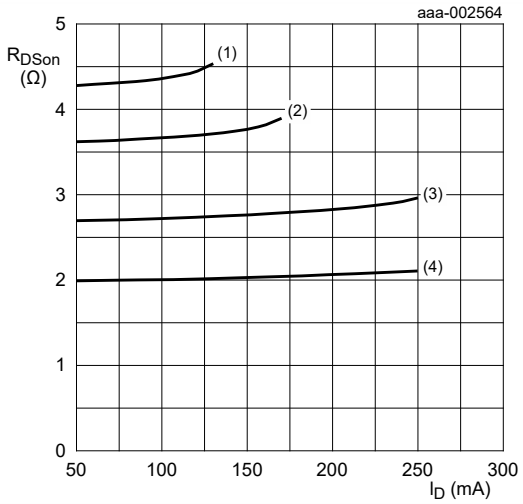
T_{amb} = 25 °C.

Fig. 15. Avalanche current (peak) versus time duration of avalanche



T_{amb} = -40 °C to 125 °C; V_{CC} = 5 V.

Fig. 16. Supply current versus frequency



V_I = V_{CC} or GND and V_O = GND or V_{CC}.

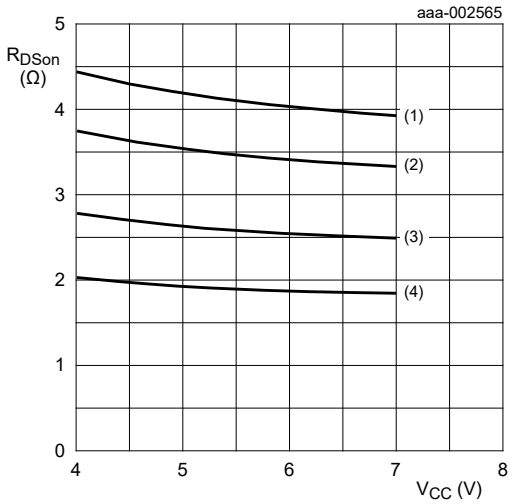
(1) T_{amb} = 125 °C

(2) T_{amb} = 85 °C

(3) T_{amb} = 25 °C

(4) T_{amb} = -40 °C

Fig. 17. Drain-source on-state resistance versus drain current



V_I = V_{CC} or GND and V_O = open circuit.

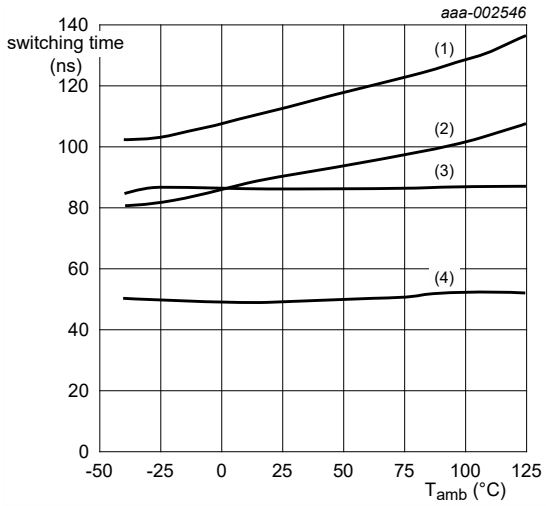
(1) T_{amb} = 125 °C

(2) T_{amb} = 85 °C

(3) T_{amb} = 25 °C

(4) T_{amb} = -40 °C

Fig. 18. Static drain-source on-state resistance versus supply voltage



Technique should limit T_J - T_C to 10 °C maximum.

(1) t_{PLH}.

(2) t_r.

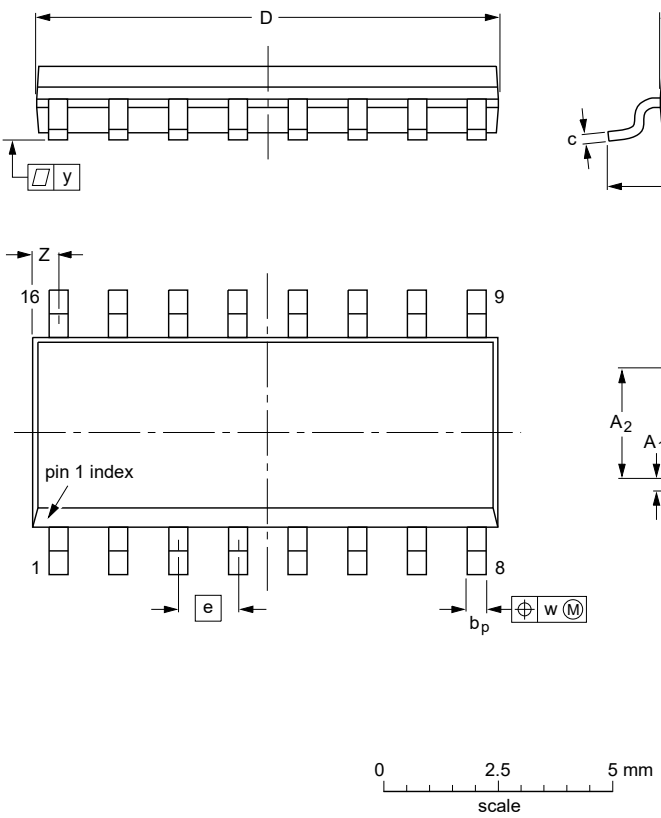
(3) t_f.

(4) t_{PHL}.

Fig. 19. Switching time versus case temperature

11. Package outline

SO16: plastic small outline package; 16 leads; body width 3.9 mm **SOT109-1**



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A_1	A_2	A_3	b_p	c	$D^{(1)}$	$E^{(1)}$	e	H_E	L	L_p	Q	v	w	y	$Z^{(1)}$	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	10.0 9.8	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8^{o} 0^{o}
inches	0.069	0.010 0.004	0.057 0.049	0.01	0.019 0.014	0.0100 0.0075	0.39 0.38	0.16 0.15	0.05	0.244 0.228	0.041	0.039 0.016	0.028 0.020	0.01	0.01	0.004	0.028 0.012	

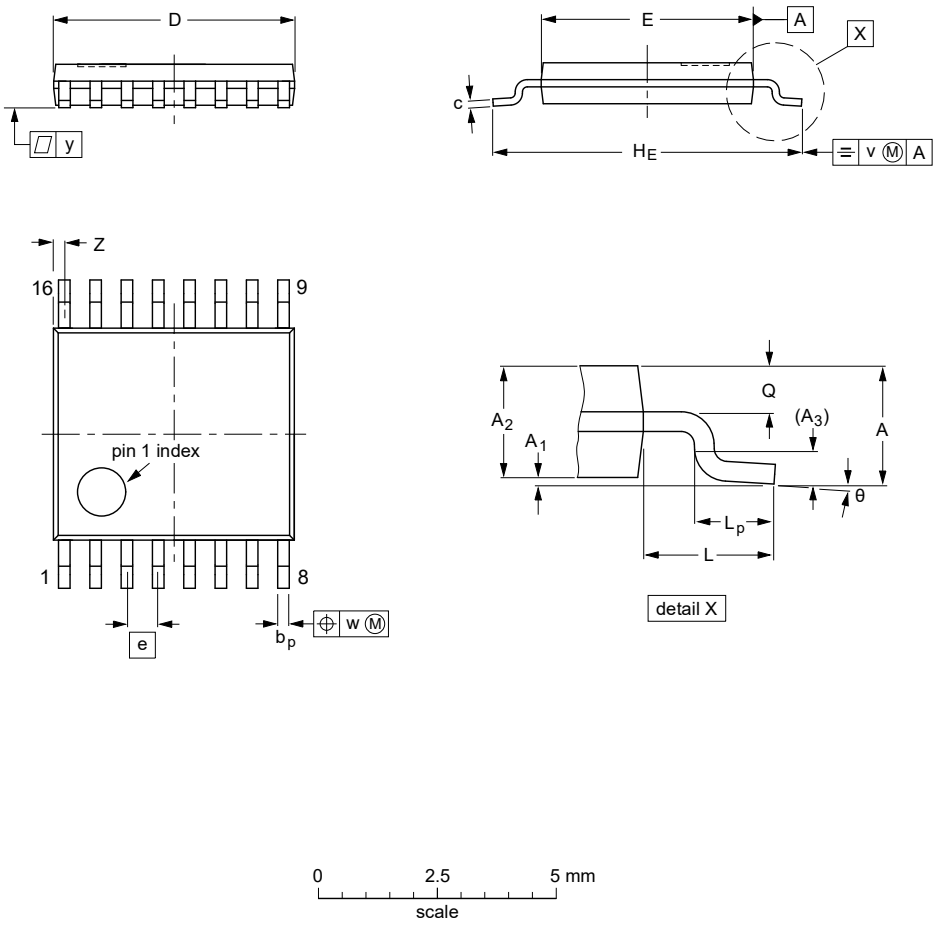
Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT109-1	076E07	MS-012				~~99-12-27~~ 03-02-19

Fig. 20. Package outline SOT109-1 (SO16)

TSSOP16: plastic thin shrink small outline package; 16 leads; body width 4.4 mm **SOT403-1**



DIMENSIONS (mm are the original dimensions)

UNIT	A max.	A_1	A_2	A_3	b_p	c	D (1)	E (2)	e	H_E	L	L_p	Q	v	w	y	Z (1)	θ
mm	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	5.1 4.9	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.40 0.06	8° 0°

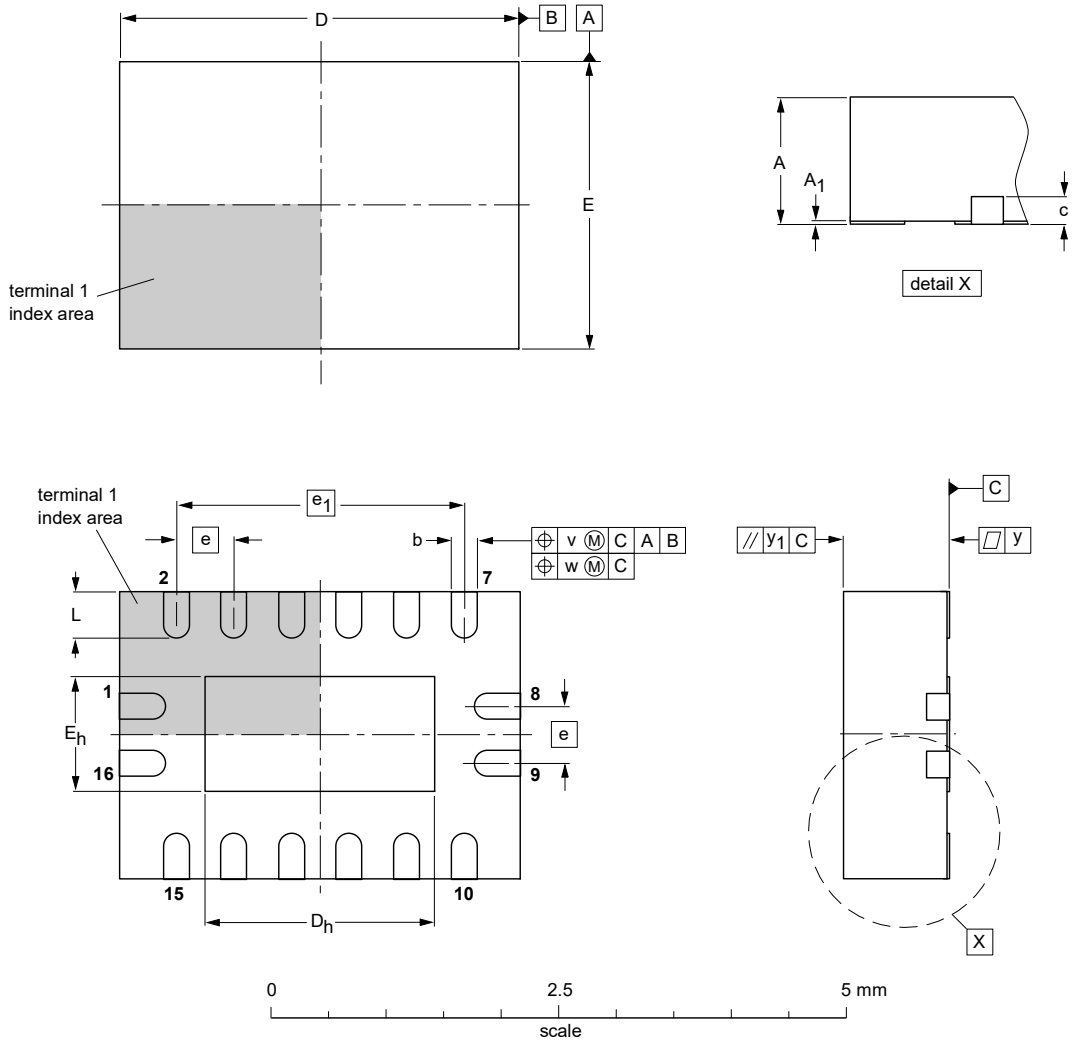
Notes

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT403-1		MO-153				~~99-12-27~~ 03-02-18

Fig. 21. Package outline SOT403-1 (TSSOP16)

DHVQFN16: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 16 terminals; body 2.5 x 3.5 x 0.85 mm **SOT763-1**



DIMENSIONS (mm are the original dimensions)

UNIT	$A^{(1)}$ max.	A_1	b	c	$D^{(1)}$	D_h	$E^{(1)}$	E_h	e	e_1	L	v	w	y	y_1
mm	1	0.05 0.00	0.30 0.18	0.2	3.6 3.4	2.15 1.85	2.6 2.4	1.15 0.85	0.5	2.5	0.5 0.3	0.1	0.05	0.05	0.1

Note

1. Plastic or metal protrusions of 0.075 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT763-1	- - -	MO-241	- - -			~~02-10-17~~ 03-01-27

Fig. 22. Package outline SOT763-1 (DHVQFN16)

12. Abbreviations

Table 10. Abbreviations

Acronym	Description
CDM	Charged Device Model
CMOS	Complementary Metal Oxide Semiconductor
DUT	Device Under Test
EDNMOS	Extended Drain Negative Metal Oxide Semiconductor
ESD	ElectroStatic Discharge
HBM	Human Body Model
TTL	Transistor-Transistor Logic

13. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
NPIC6C596A_Q100 v.2	20200626	Product data sheet	-	NPIC6C596A_Q100 v.1
Modifications:	• The format of this data sheet has been redesigned to comply with the identity guidelines of Nexperia. • Legal texts have been adapted to the new company name where appropriate. • Section 2 updated.			
NPIC6C596A_Q100 v.1	20131018	Product data sheet	-	-

14. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.
[2] The term 'short data sheet' is explained in section "Definitions".
[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the internet at https://www.nexperia.com.

Definitions

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. Nexperia does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local Nexperia sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

Product specification — The information and data provided in a Product data sheet shall define the specification of the product as agreed between Nexperia and its customer, unless Nexperia and customer have explicitly agreed otherwise in writing. In no event however, shall an agreement be valid in which the Nexperia product is deemed to offer functions and qualities beyond those described in the Product data sheet.

Disclaimers

Limited warranty and liability — Information in this document is believed to be accurate and reliable. However, Nexperia does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information. Nexperia takes no responsibility for the content in this document if provided by an information source outside of Nexperia.

In no event shall Nexperia be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory.

Notwithstanding any damages that customer might incur for any reason whatsoever, Nexperia's aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the Terms and conditions of commercial sale of Nexperia.

Right to make changes — Nexperia reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use in automotive applications — This Nexperia product has been qualified for use in automotive applications. Unless otherwise agreed in writing, the product is not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an Nexperia product can reasonably be expected to result in personal injury, death or severe property or environmental damage. Nexperia and its suppliers accept no liability for inclusion and/or use of Nexperia products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

Quick reference data — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

Applications — Applications that are described herein for any of these products are for illustrative purposes only. Nexperia makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Customers are responsible for the design and operation of their applications and products using Nexperia products, and Nexperia accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the Nexperia product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products.

Nexperia does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using Nexperia products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). Nexperia does not accept any liability in this respect.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) will cause permanent damage to the device. Limiting values are stress ratings only and (proper) operation of the device at these or any other conditions above those given in the Recommended operating conditions section (if present) or the Characteristics sections of this document is not warranted. Constant or repeated exposure to limiting values will permanently and irreversibly affect the quality and reliability of the device.

Terms and conditions of commercial sale — Nexperia products are sold subject to the general terms and conditions of commercial sale, as published at http://www.nexperia.com/profile/terms, unless otherwise agreed in a valid written individual agreement. In case an individual agreement is concluded only the terms and conditions of the respective agreement shall apply. Nexperia hereby expressly objects to applying the customer's general terms and conditions with regard to the purchase of Nexperia products by customer.

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from competent authorities.

Translations — A non-English (translated) version of a document is for reference only. The English version shall prevail in case of any discrepancy between the translated and English versions.

Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

Contents

For more information, please visit: http://www.nexperia.com
For sales office addresses, please send an email to: salesaddresses@nexperia.com
Date of release: 26 June 2020

OUR CERTIFICATE

DiGi provide top-quality products and perfect service for customer worldwide through standardization, technological innovation and continuous improvement. DiGi through third-party certification, we striciy control the quality of products and services. Welcome your RFQ to Email: Info@DiGi-Electronics.com

Tel: +00 852-30501935

RFQ Email: Info@DiGi-Electronics.com

DiGi is a global authorized distributor of electronic components.